What is claimed is:

- 1. A method of decomposing timing jitter on a signal under test (SUT) comprising an arbitrary serial data stream, said method comprising:
- forming a group of measurements, where each measurement comprises a timing jitter value and an associated bit pattern representing the bits falling within an analysis window of a chosen length, said window being successively located at a plurality of positions within the SUT; and

performing a statistical analysis on said group of measurements to

10 calculate the mean value of the inter-symbol interference (ISI) associated with
each bit pattern.

2. The method of claim 1, wherein said ISI jitter is determined for a specified edge polarity only.

3. The method of claim 1, further comprising separating random and periodic jitter.

- 4. The method of claim 1, further comprising estimating duty cycle distortion 20 (DCD).
 - 5. The method of claim 4, further comprising removing said DCD from a record.
- 25 6. The method of claim 4, further comprising estimating the probability density function (PDF) of said ISI plus said DCD.
 - 7. The method of claim 1, further comprising removing said ISI from a record.

8. The method of claim 1, further comprising estimating the probability density function (PDF) of said ISI.

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A test and measurement device, comprising:
 an acquisition module, for acquiring a first SUT to produce a first sample

a processing module, for

stream;

forming a group of measurements, where each measurement comprises a timing jitter value and an associated bit pattern representing the bits falling within an analysis window of a chosen length, said window being successively located at a plurality of positions within the SUT, and

performing a statistical analysis on said group of measurements to 10 calculate the mean value of the inter-symbol interference (ISI) associated with each bit pattern; and

a display module, for displaying results of said statistical analysis.

- 10. The test and measurement device of claim 9, wherein said processing15 module is further for determining said ISI jitter for a specified edge polarity only.
 - 11. The test and measurement device of claim 9, wherein said processing module is further for separating random and periodic jitter.
- 20 12. The test and measurement device of claim 9, wherein said processing module is further for estimating duty cycle distortion (DCD).
 - 13. The test and measurement device of claim 9, wherein said processing module is further for removing said DCD from a record.
 - 14. The test and measurement device of claim 9, wherein said processing module is further for removing said ISI from a record.
- 15. A computer-readable media for storing software instructions which when30 executed by a processor perform the steps of:

decomposing timing jitter on a signal under test (SUT) comprising an arbitrary serial data stream, by

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forming a group of measurements, where each measurement comprises a timing jitter value and an associated bit pattern representing the bits falling within an analysis window of a chosen length, said window being successively located at a plurality of positions within the SUT; and

- performing a statistical analysis on said group of measurements to calculate the mean value of the inter-symbol interference (ISI) associated with each bit pattern.
- 16. The computer-readable media of claim 15, wherein said ISI jitter is10 determined for a specified edge polarity only.

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- 17. The computer-readable media of claim 15, further comprising instructions for separating random and periodic jitter.
- 15 18. The computer-readable media of claim 15, further comprising instructions for estimating duty cycle distortion (DCD).
 - 19. The computer-readable media of claim 15, further comprising instructions for removing said DCD from a record.
 - 20. The computer-readable media of claim 15, further comprising instructions for removing said ISI from a record.

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